

# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Substitute for form 1449A/PTO

Sheet 1 of 3  
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Complete if Known  
Applicant Number NEW APPLICATION  
Filing Date HEREWITH  
First Named Inventor Oh-Hun Kwon, et al.  
Group Art Unit  
Examiner Name  
Attorney Docket Number 1035-PM4034-DIV

10/689192

## U.S. PATENT DOCUMENTS

| Examiner Initials * | Cite No. 1 | U.S. Patent Document Number | Kind Code 2 (if known) | Name of Patentee or Applicant of Cited Document | Date of Publication of Cited Document MM-DD-YYYY | Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear |
|---------------------|------------|-----------------------------|------------------------|---|--|---|
|                     | AA         | 2,528,121                   |                        | Dickinson                                       | 05/20/1948                                       |   |
|                     | AB         | 3,502,597                   |                        | Bush  | 03/24/1970                                       |   |
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|                     | AD         | 4,316,964                   |                        | Lange   | 02/23/1982                                       |   |
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|                     | AF         | 5,612,144                   |                        | Aida, et al.                                    | 09/28/1999                                       |   |
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|                     | AH         | 5,958,813                   |                        | Shinohara, et al.                               | 03/18/1997                                       |   |
|                     | AI         | 6,136,232                   |                        | Burlingame                                      | 10/24/2000                                       |   |
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|---------------------|------------|----------------------------------|-----------|------------------------|---|--|---|--------------------------|
|                     | AK         | JP                               | 3-5363    |                        |   | 01/11/1999                                       |   | <input type="checkbox"/> |
|                     | AL         | DE                               | 3743630   |                        |   | 03/16/1989                                       |   | <input type="checkbox"/> |
|                     | AM         | JP                               | 62-025404 | A                      |   | 08/12/1994                                       |   | <input type="checkbox"/> |
|                     | AN         | JP                               | 8-039441  |                        | Hideharu Hasegawa                               | 02/13/1996                                       |   | <input type="checkbox"/> |
|                     | AO         | JP                               | 10-296646 | A                      | Hiroshi Hamashima                               | 11/10/1998                                       |   | <input type="checkbox"/> |

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| Examiner Initials * | Cite No. 1 | Title of Publication  | Date of Publication of Cited Document MM-DD-YYYY |
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| Examiner Signature |  | Date Considered | 3/28/2005 |
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|                     | BC        | 6,069,103                   |                        | Kwon, et al.                                    | 05/30/2000                                       |   |
|                     | BD        | 6,379,529                   |                        | Wahl, et al.                                    | 04-2002  |   |
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|---------------------|-----------|----------------------------------|----------|------------------------|---|--|---|--------------------------|
|                     | BK        | WO                               | 98/49121 |                        | Shunji Mikaki                                   | 11/05/1998                                       |   | <input type="checkbox"/> |
|                     | BL        |                                  |          |                        |   |  |   | <input type="checkbox"/> |
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|                     | BO        |                                  |          |                        |   |  |   | <input type="checkbox"/> |

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|                     | BW        | K.J. Kim, et al., "Advancements in Inherently Dissipative Polymer (IDP) Alloys Provide New Levels of Clean, Consistent ESD Protection," EOS/ESD Symposium 2000, pp. 132-38, 2000. |  |
|                     | BX        | R.V. Wilhelm, D.S. Howarth, "Iron Oxide-doped Ytria-Stabilized zirconia Ceramic: Iron Solubility and Electrical Conductivity," Am. Ceram. Soc. Bull., 58 (2) 228-32 (1979).       |  |
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|                     | BZ        | ASTM: D257-93, "Standard Test Methods for DC Resistance or Conductance of Insulating Materials," pp. 108-124.   |  |

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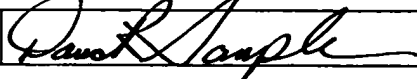
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|   | AAE       | M.J. DeBarr, et al., "Conduction Mechanism in the La(Al,Mn) <sub>3</sub> System," Point Defects and Related Properties of Ceramics, ED. T.O. Mason, et al., Ceramic Trans., Vol. 24, am. Ceram. Soc., pp. 229-238, 1991. |  |
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